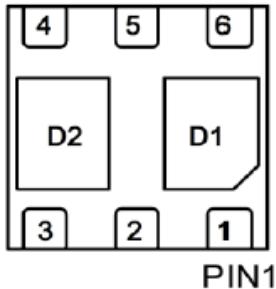
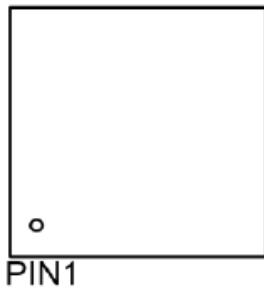


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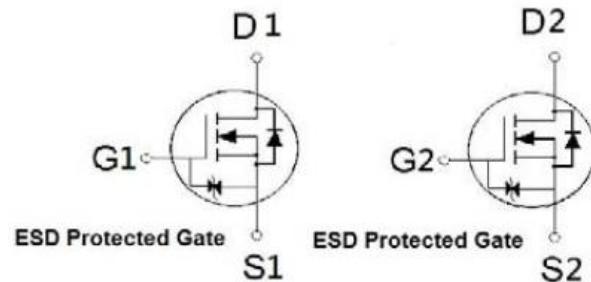
Dual N-Channel Enhancement Mode MOSFET

PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
20V	35mΩ @ $V_{GS} = 4.5V$	5A



PDFN 2X2S



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 8	V
Continuous Drain Current	I_D	5	A
$T_A = 70^\circ C$		3.9	
Pulsed Drain Current ¹	I_{DM}	20	
Power Dissipation	P_D	1.4	W
$T_A = 70^\circ C$		0.9	
Operating Junction & Storage Temperature Range	T_J, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$R_{\theta JA}$		86	°C / W

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper.

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Dual N-Channel Enhancement Mode MOSFET

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

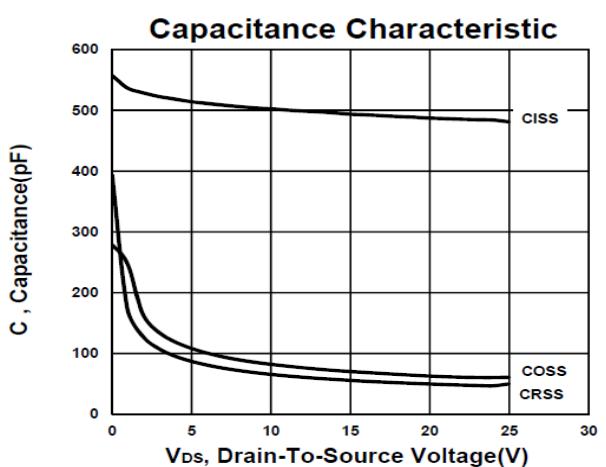
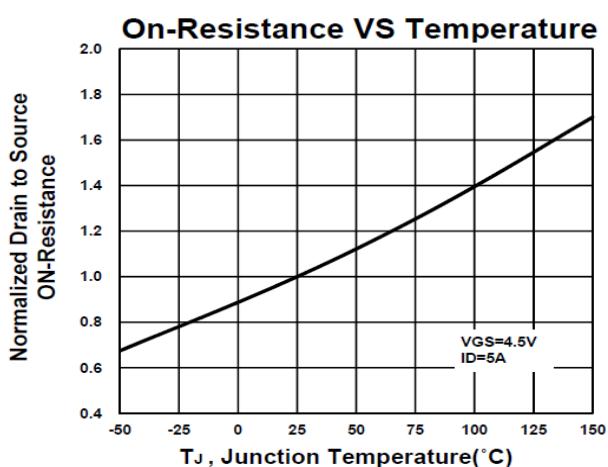
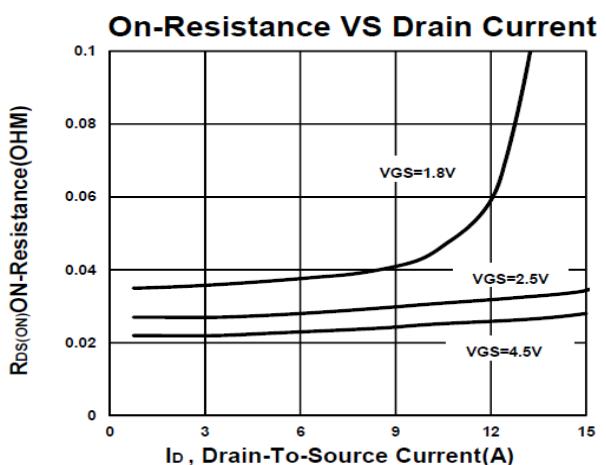
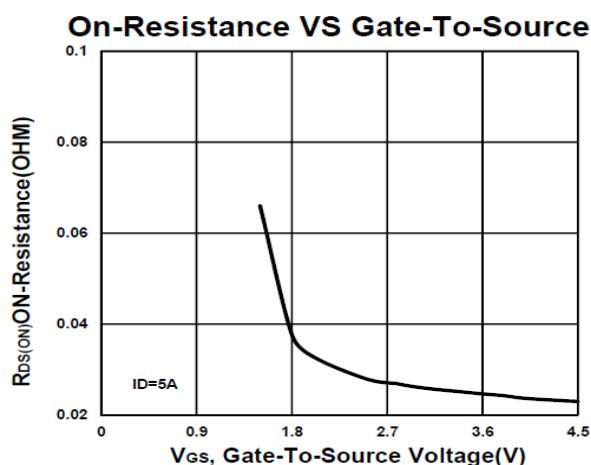
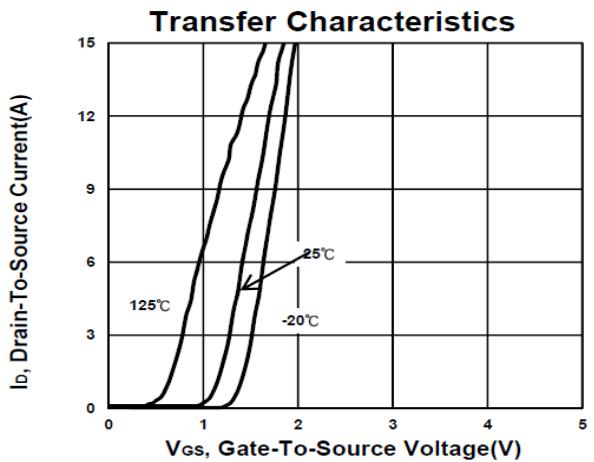
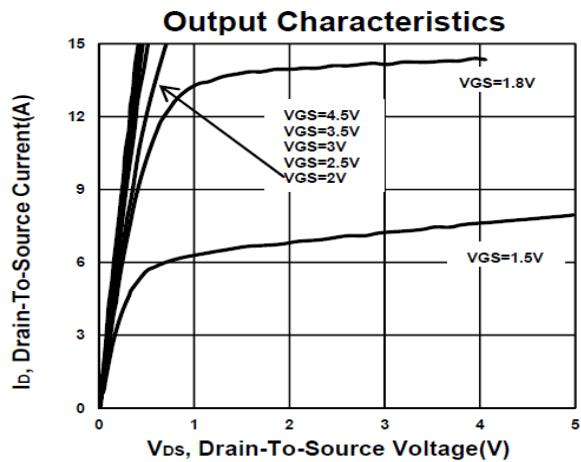
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	20			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	0.5	0.7	1.0	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 8\text{V}$			± 10	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 16\text{V}, V_{\text{GS}} = 0\text{V}$			1	μA
		$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 55^\circ\text{C}$			10	
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 4.5\text{V}, I_D = 5\text{A}$		22	35	$\text{m}\Omega$
		$V_{\text{GS}} = 2.5\text{V}, I_D = 4.5\text{A}$		27	38	
		$V_{\text{GS}} = 1.8\text{V}, I_D = 2\text{A}$		35	55	
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = 5\text{V}, I_D = 5\text{A}$		30		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 10\text{V}, f = 1\text{MHz}$		506		pF
Output Capacitance	C_{oss}			82		
Reverse Transfer Capacitance	C_{rss}			66		
Gate Resistance	R_g	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$		1.8		Ω
Total Gate Charge ²	$Q_g(V_{\text{GS}}=4.5\text{V})$	$V_{\text{DS}} = 10\text{V}, I_D = 5\text{A}$		7		nC
	$Q_g(V_{\text{GS}}=2.5\text{V})$			4.3		
Gate-Source Charge ²	Q_{gs}			0.6		
Gate-Drain Charge ²	Q_{gd}			2.3		
Turn-On Delay Time ²	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 10\text{V}, I_D \geq 5\text{A}, V_{\text{GEN}} = 4.5\text{V}, R_G = 6\Omega$		12		nS
Rise Time ²	t_r			35		
Turn-Off Delay Time ²	$t_{\text{d}(\text{off})}$			24		
Fall Time ²	t_f			16		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ\text{C}$)						
Continuous Current	I_S				1.4	A
Forward Voltage ¹	V_{SD}	$I_F = 5\text{A}, V_{\text{GS}} = 0\text{V}$			1	V
Reverse Recovery Time	t_{rr}	$I_F = 5\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		8.8		nS
Reverse Recovery Charge	Q_{rr}			1.4		nC

¹Pulse test : Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

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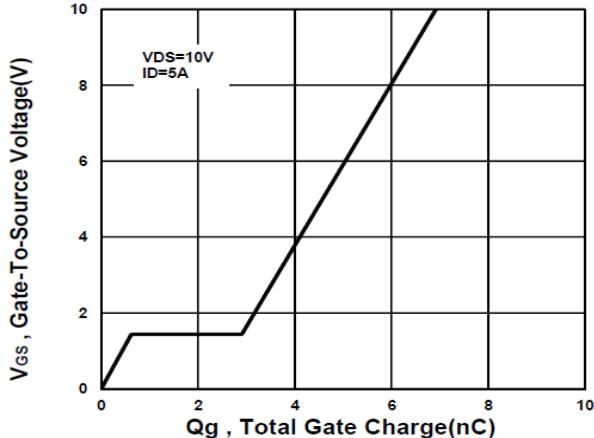
Dual N-Channel Enhancement Mode MOSFET



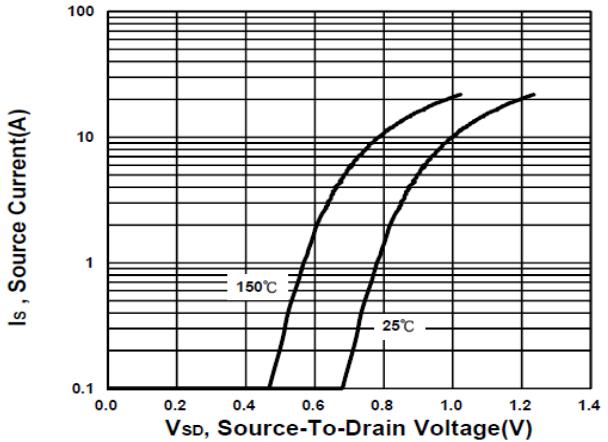
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Dual N-Channel Enhancement Mode MOSFET

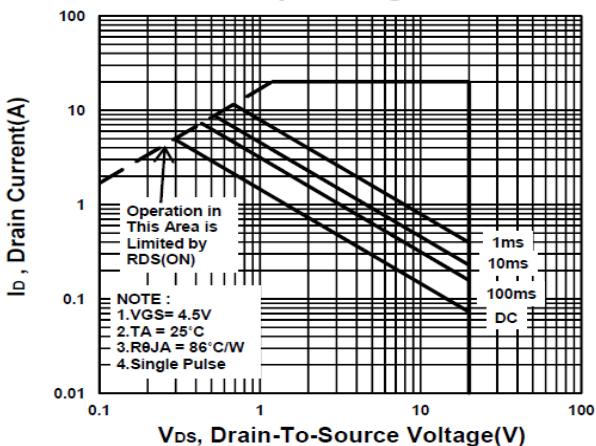
Gate charge Characteristics



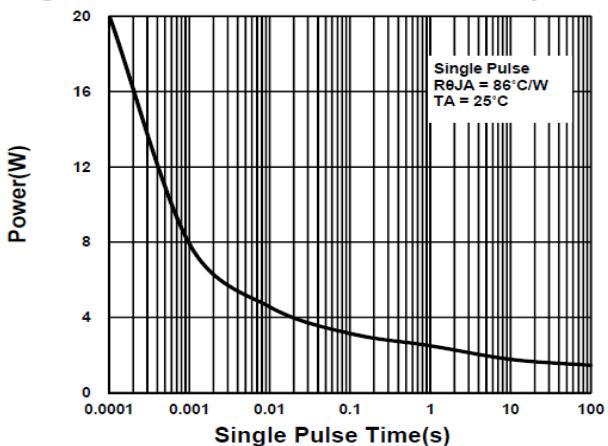
Source-Drain Diode Forward Voltage



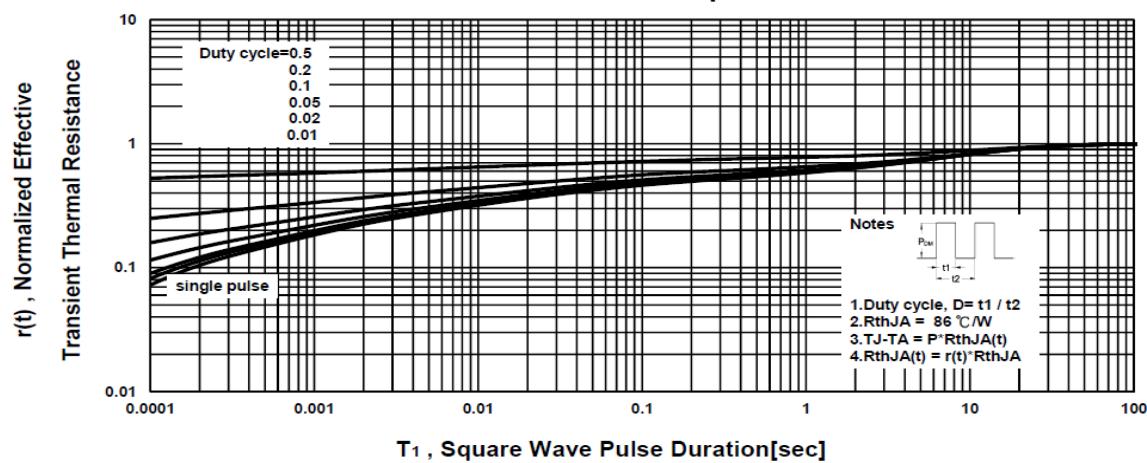
Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve



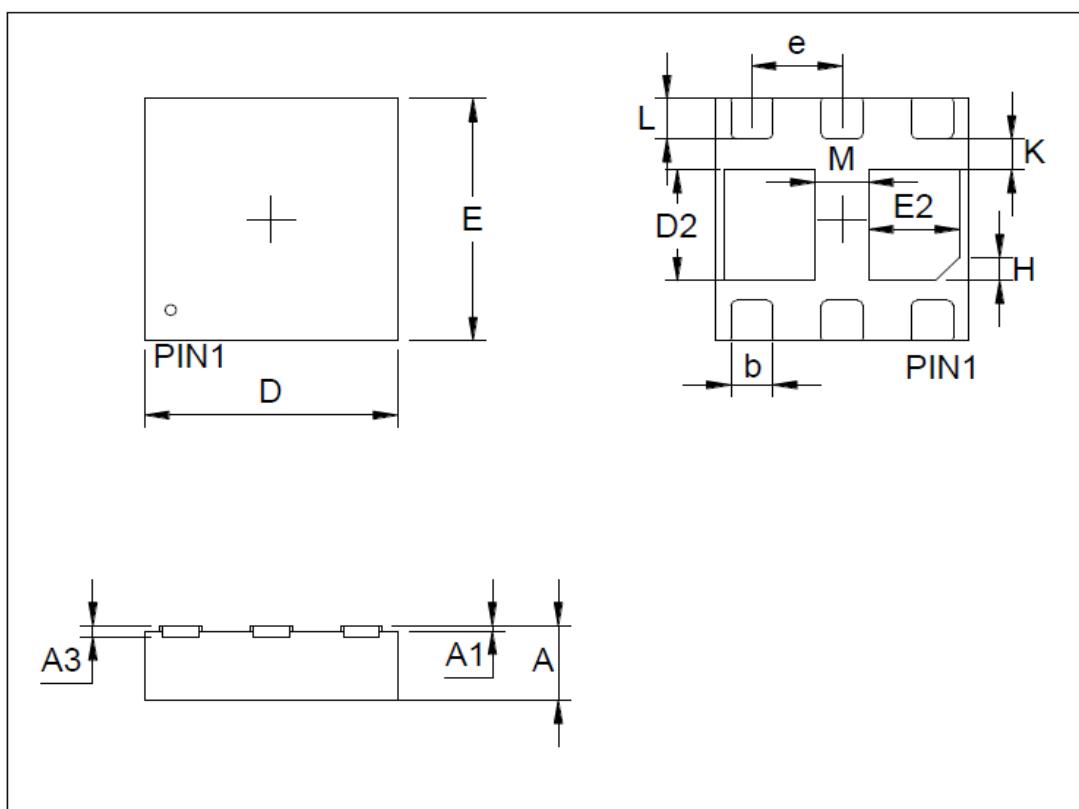
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Dual N-Channel Enhancement Mode MOSFET

Package Dimension

PDFN 2x2S (Dual) MECHANICAL DATA

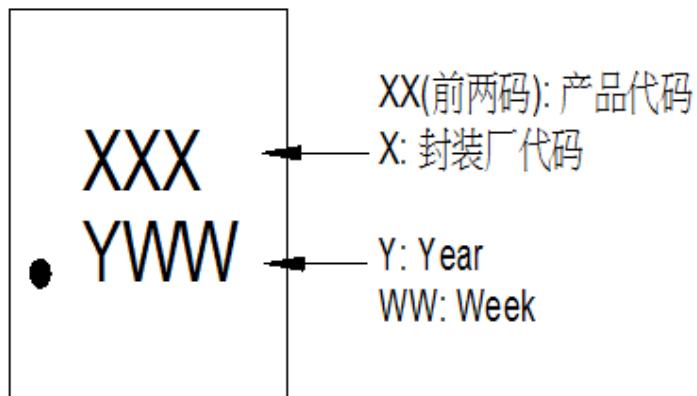
Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	0.50	0.55	0.65	e	0.55	0.65	0.75
A1	0.00	0.02	0.05	H	0.20REF		
A3	0.10REF			K	0.17	0.27	0.37
b	0.25	0.30	0.35	L	0.25	0.30	0.35
D	1.90	2.00	2.10	M	0.25	0.35	0.45
E	1.90	2.00	2.10				
D2	0.76	0.86	0.96				
E2	0.55	0.65	0.75				



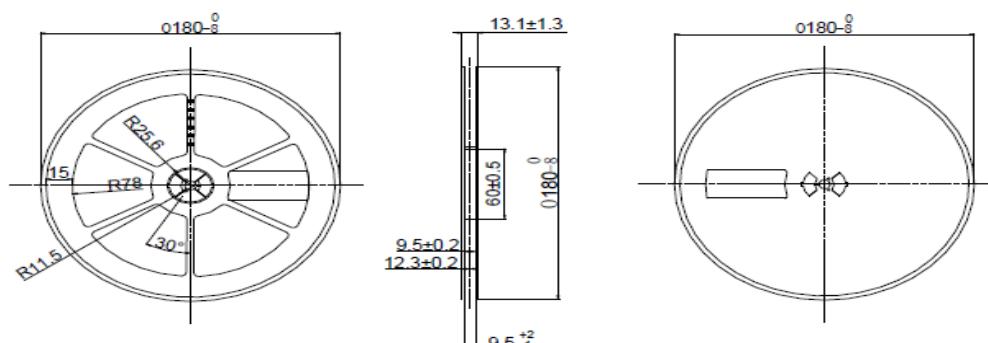
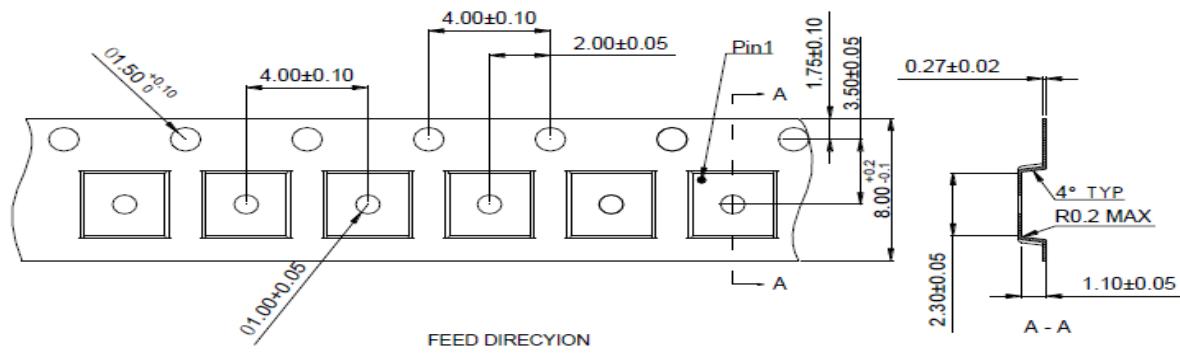
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Dual N-Channel Enhancement Mode MOSFET

A. Marking Information(此产品代码为: B9)



B. Tape&Reel Information:3000pcs/Reel

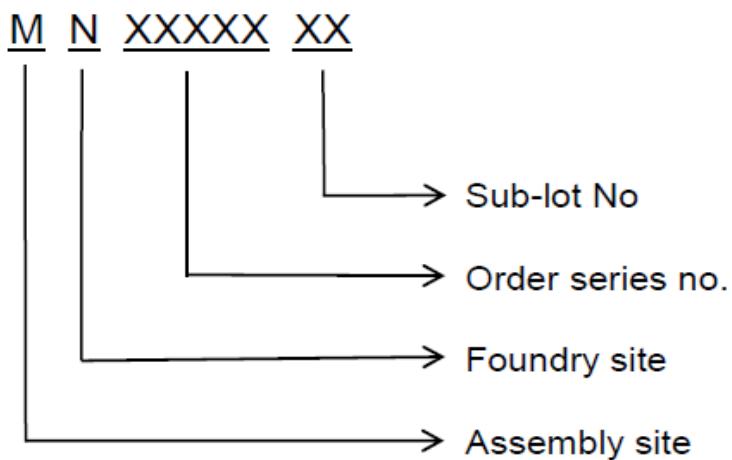


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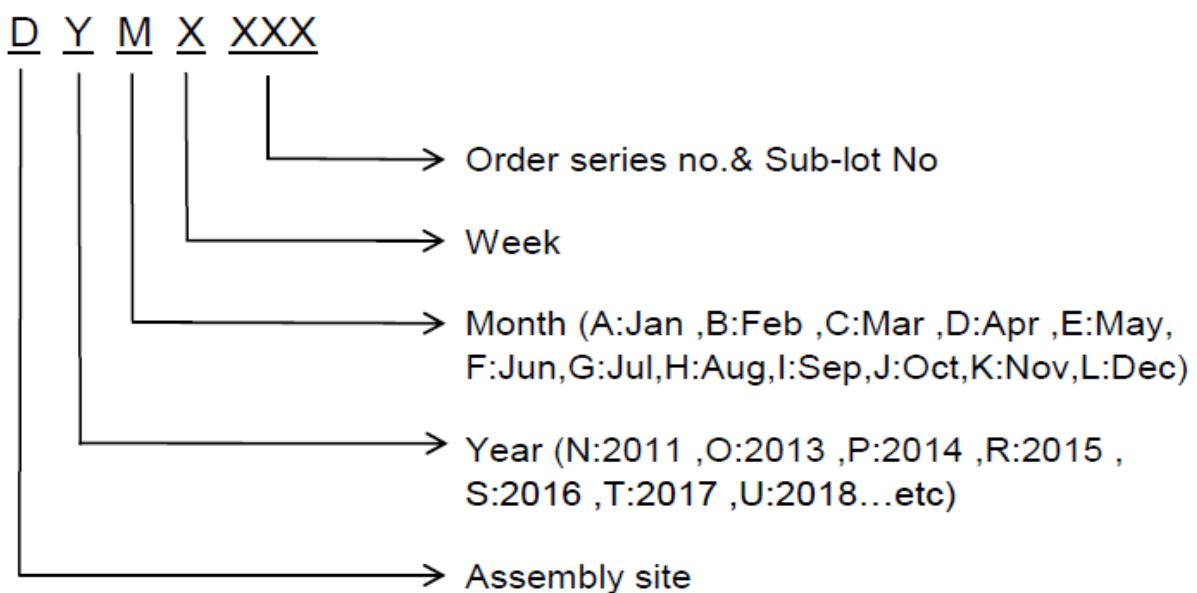
Dual N-Channel Enhancement Mode MOSFET

C. Lot No.&Date Code rule

1. Lot No.



2. Date Code



PB5G8JW

Dual N-Channel Enhancement Mode MOSFET

D.Label rule

标签内容(Label content)



1	Label Size	30 * 90 mm		
2	Font style	Times New Roman or Arial (或可区分英文“0”和数字“0”，“G”和“Q”的字型即可)		
3	U-NIKC	Height: 4 mm		
4	Package	Height: 2 mm		
5	Date	Height: 2 mm Shipping date: YYYY/MM/DD, ex. 2008/09/12		
6	Device	Height: 3 mm (Max: 16 Digit)		
7	Lot	Height: 3 mm (Max: 9 Digit) Sub lot		
8	D/C	Height: 3 mm (Max: 7 Digit)		
9	QTY	Height: 3 mm (Max: 6 Digit) Thousand mark is no needed		
10	RoHS label	RoHS long axis: 12 mm minor axis: 6 mm bottom color: White Font color: Black Font style: Arial		
11	Halogen Free label	G Diameter: 10 mm bottom color: Green Font color: Black Font style: Arial		
12	Scan information	Device / Lot / D/C / QTY , Insert “ / ” between every parts. for example: P3055LDG/G12345601/GGG2301/2000 DPI (Dots per inch): Over 300 dpi Code : Code 128 Height: 6 mm at least		